

# Slack Redistribution for Graceful Degradation Under Voltage Overscaling

Andrew B. Kahng<sup>†</sup>, **Seokhyeong Kang<sup>†</sup>**,  
Rakesh Kumar<sup>‡</sup> and John Sartori<sup>‡</sup>

<sup>†</sup>VLSI CAD LABORATORY, UCSD

<sup>‡</sup>PASSAT GROUP, UIUC

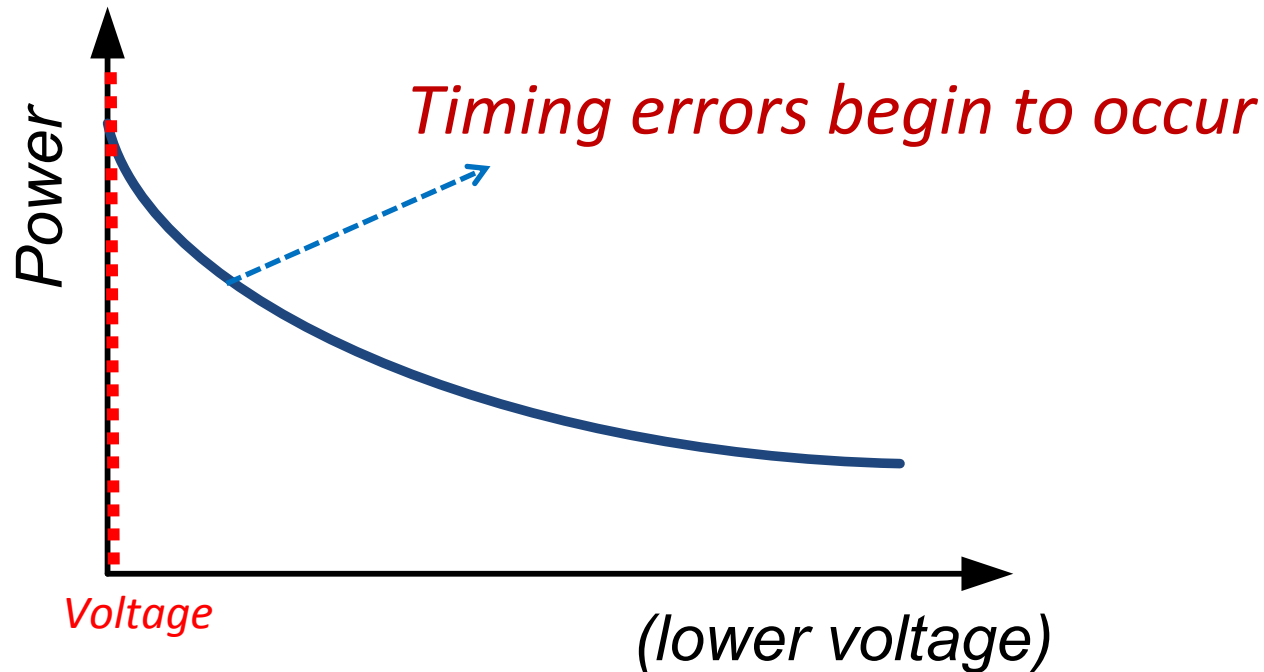
# Outline

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- Background and motivation
  - Voltage scaling and BTWC designs
  - Limitation of Traditional CAD Flow
- Power-Aware Slack Redistribution
  - Our design optimization goal
  - Related work: *BlueShift*
  - Our Heuristic
- Experimental Framework and Results
  - Design methodology
  - Testbed
  - Results and analysis
- Conclusions and Ongoing Work

# Reducing Power with Voltage Scaling

- Power is a first-order design constraint
- Voltage scaling can significantly reduce power
- Voltage scaling may result in timing violations



- *Voltage scaling is limited because of timing errors*

# Better-Than-Worst-Case Design

- Better-Than-worst-case (BTWC) design approach
  - Optimize for normal operating conditions
  - Trade off reliability and power/performance
  - Have error detection/correction mechanism (e.g., *Razor\**)

## Traditional IC design

- Does not allow timing errors in STA
- Fixed target frequency and operating voltage

## BTWC design

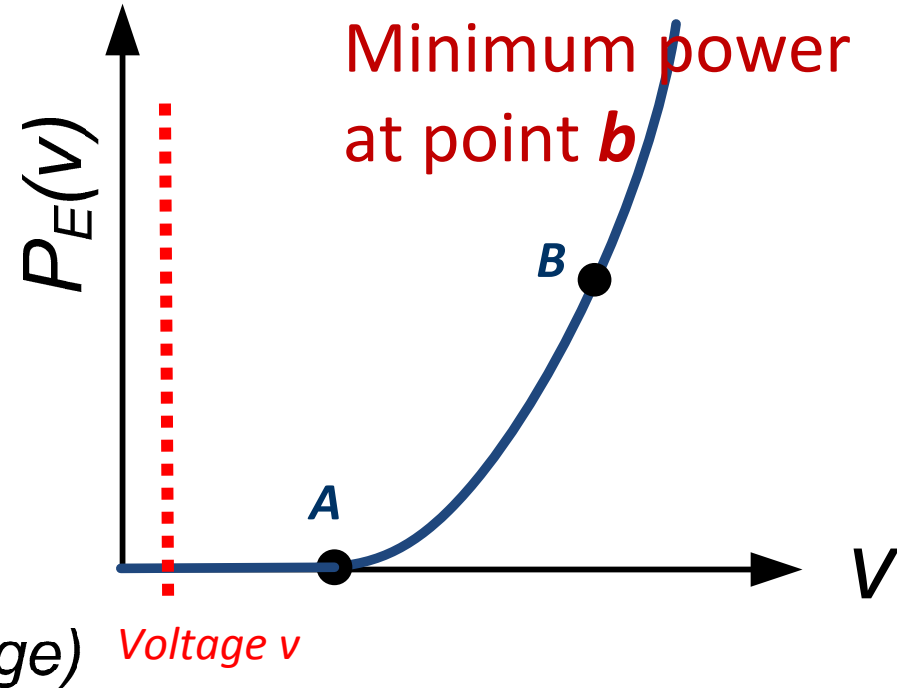
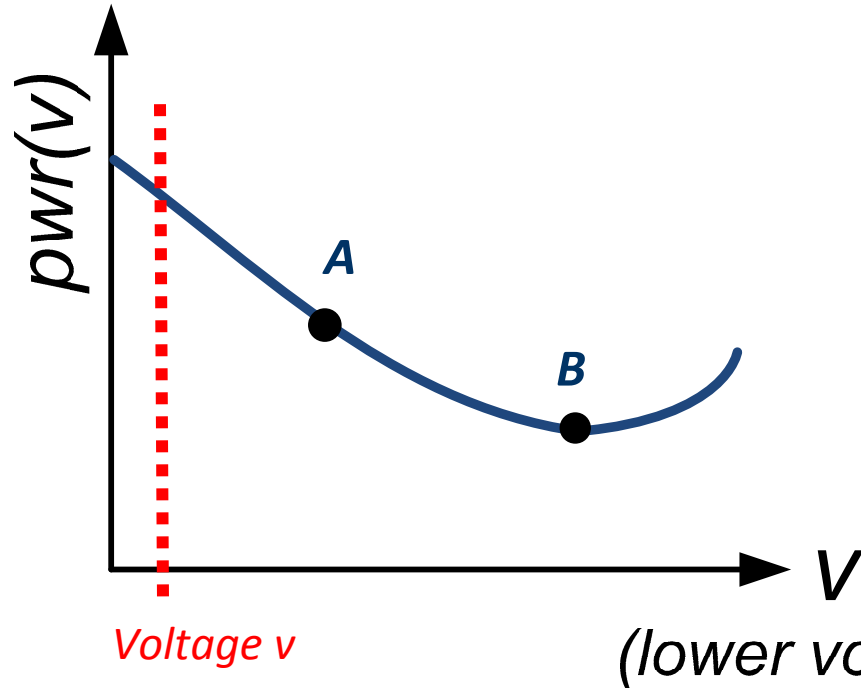
- Error correction architecture allows timing errors
- Overclocking or voltage overscaling

\* Ernst et al. "Razor: A low power pipeline based on circuit-level timing

- *BTWC design allows tradeoffs between reliability and power*

# Voltage Scaling with Error Correction

- Error correction incurs power overhead



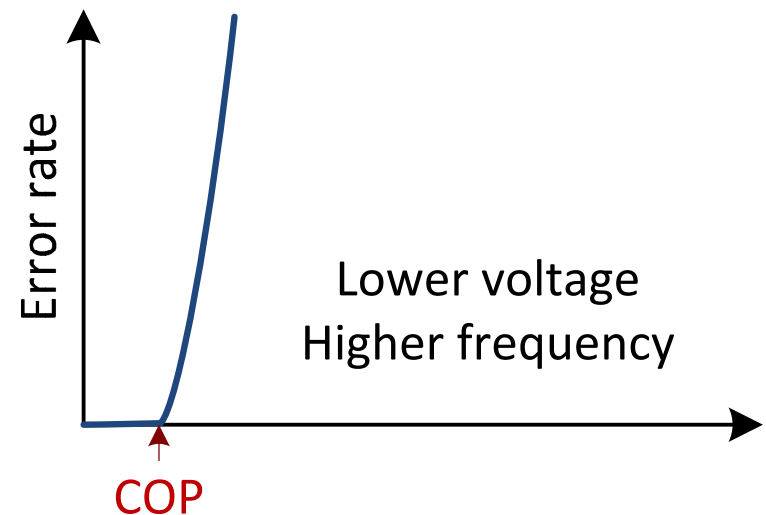
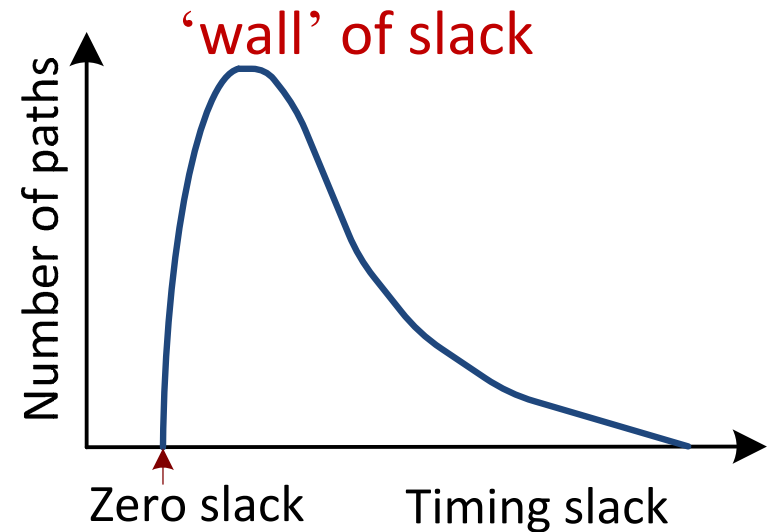
$pwr(v)$  : Power consumption at  $v$

$P_E(v)$  : Error rate at voltage  $v$

- *Overscaling is possible for Better-Than-Worst-Case designs*

# Limitations of Traditional CAD Flow

- Conventional designs exhibit critical operating points
  - Many paths have near-critical slack → *wall of (critical) slack*
  - Scaling beyond *COP* causes massive errors that cannot be corrected
  - Conventional designs fail critically when voltage is scaled down
- Error rate should be increased gracefully :  
*gradual slope slack*



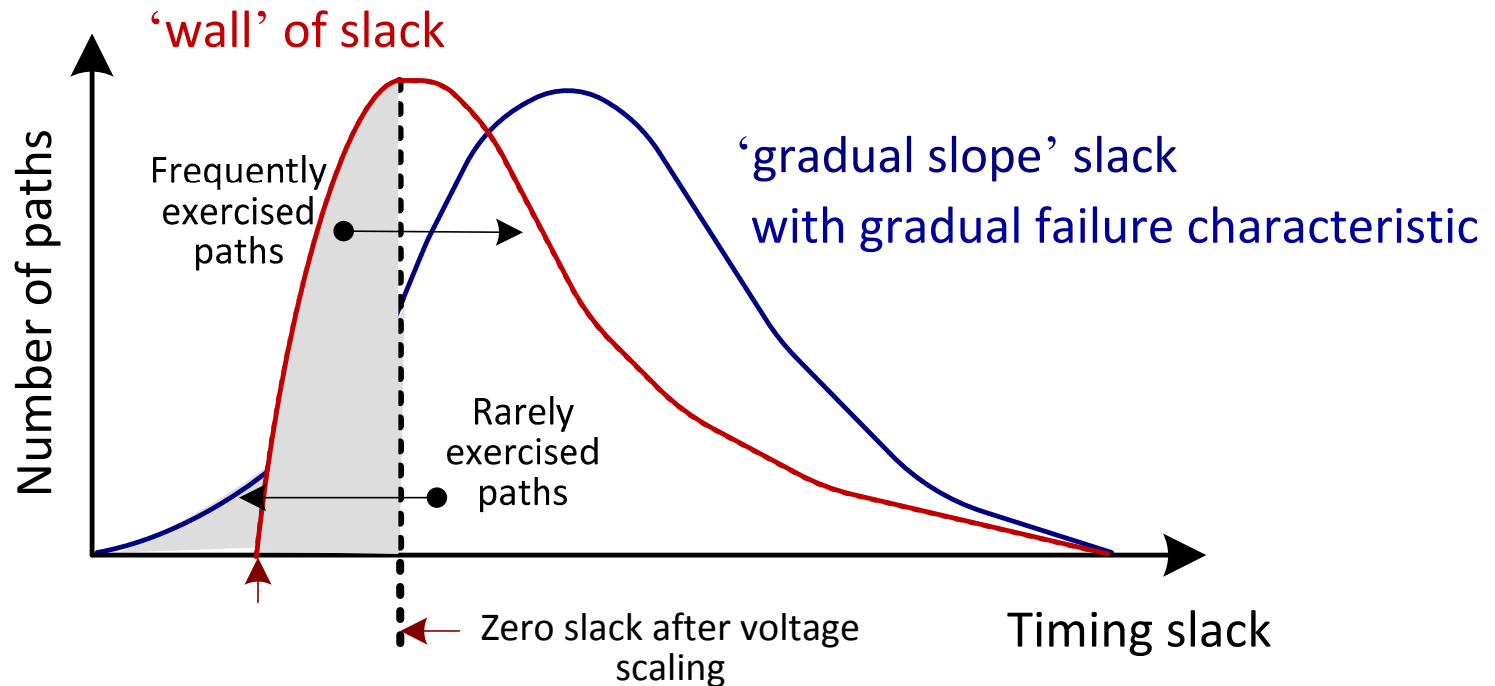
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# Our Design Optimization Goal

- **Problem:** Minimize power for a given error rate
- **Goal:** Achieve a ***‘gradual slope’*** slack distribution
- **Approach:** Frequently-exercised paths: upsize cells  
Rarely-exercised paths: downsize cells

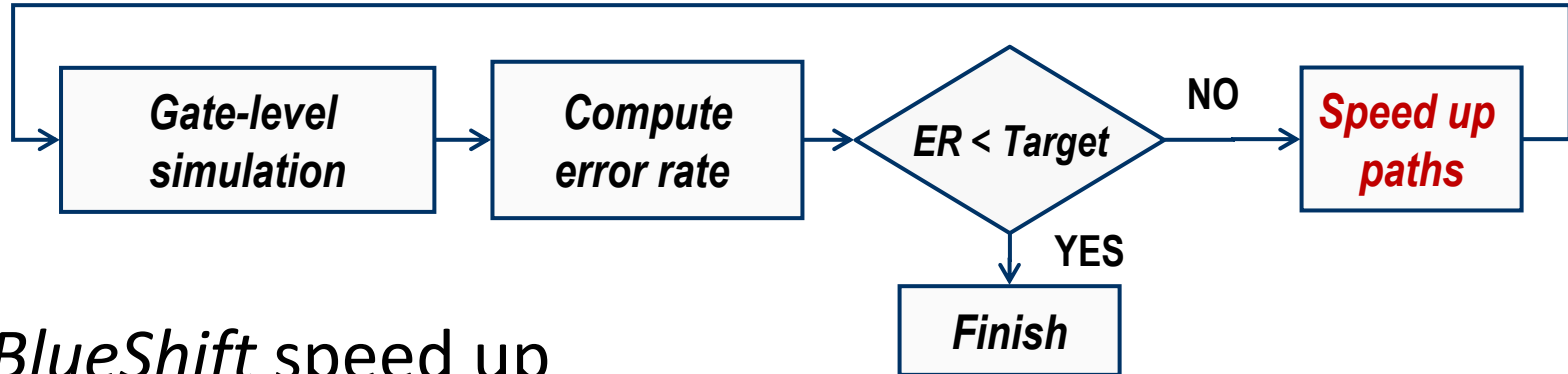


- *We make a gradual slope slack distribution*



# Related Work: *BlueShift*

- *BlueShift*\* : maximize frequency for a given error rate



- *BlueShift* speed up

- Paths with the highest frequency of timing errors
- FBB (forward body-biasing) & Timing override

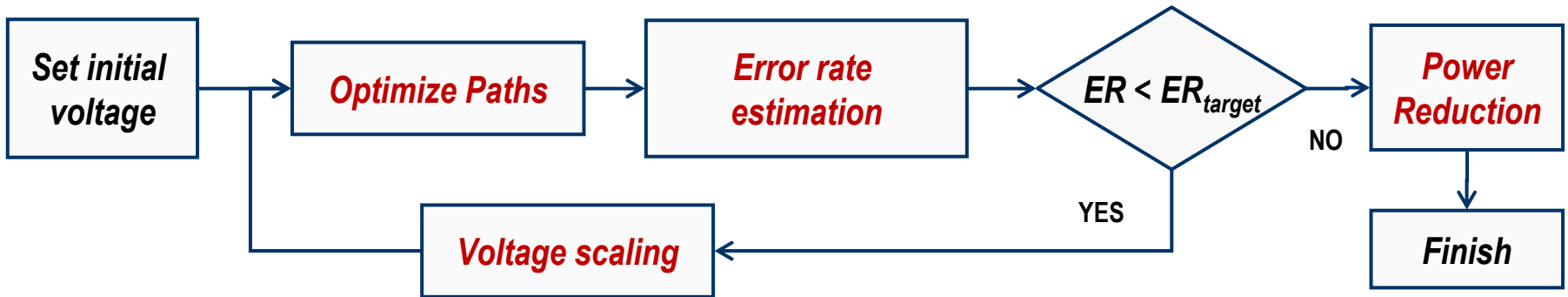
- **Limitation** Chen et al. "Blueshift: Designing processors for timing speculation from the ground up", HPCA 2009

- Repetitive gate level simulation – impractical
- Design overhead of FBB

- *BlueShift is impractical with modern SOC designs*

# Our Heuristic

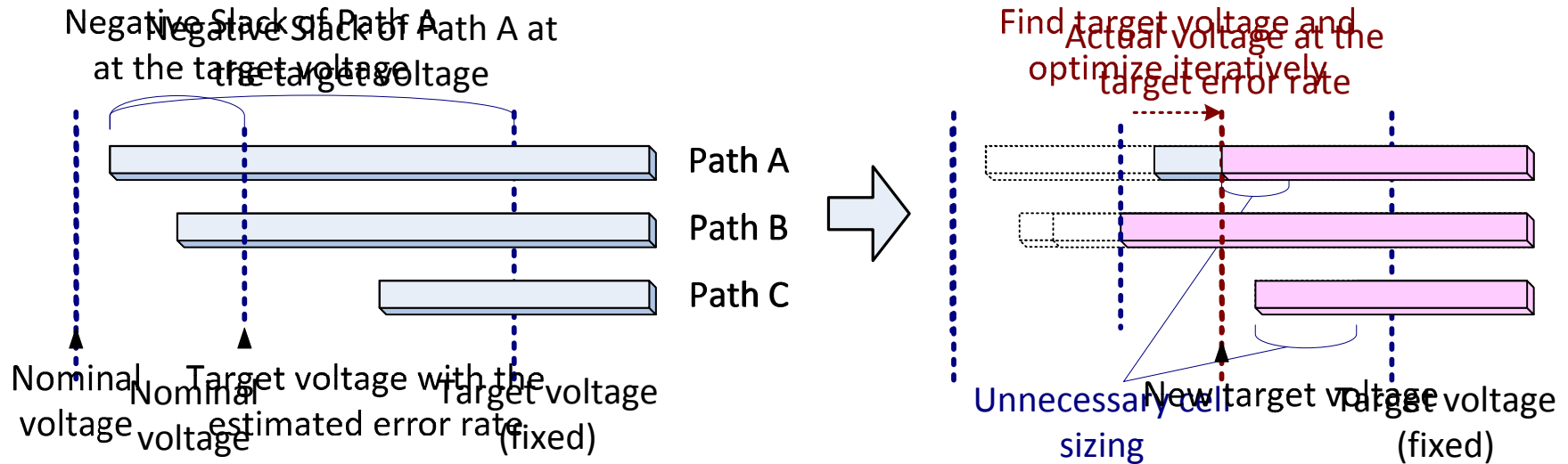
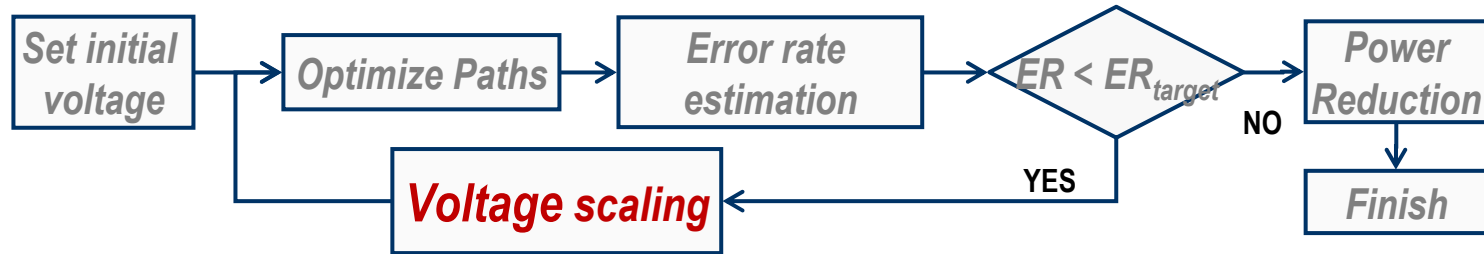
- Optimize slack distribution by cell swaps, exploiting switching activity information
- Iteratively scale target voltage the until error rate exceeds a target, and optimize negative slack paths



- *Our heuristic:*

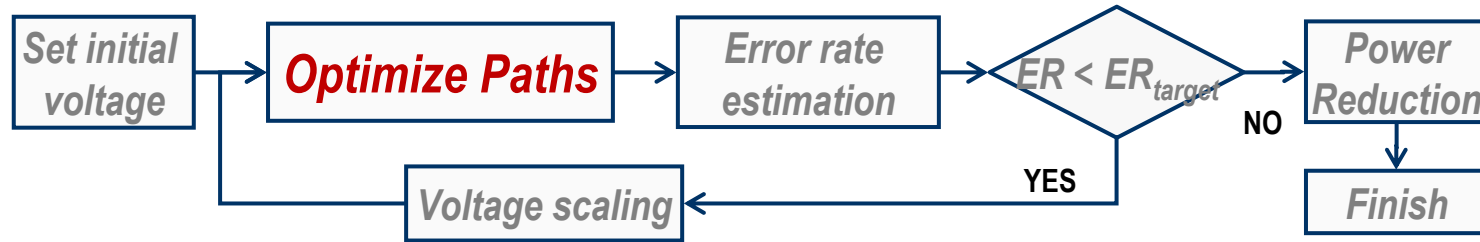
*Voltage scaling* → *Optimize paths* → *Power reduction*

# Heuristic Implementation – Voltage Scaling



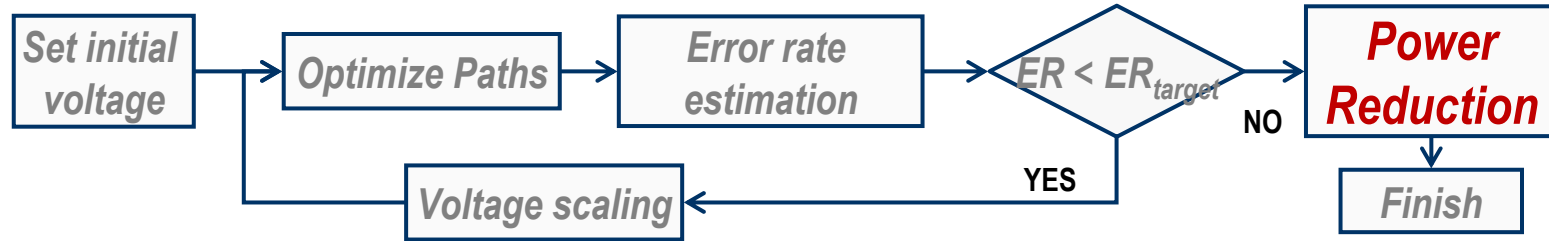
- Optimize with fixed target voltage
- Load a pre-characterized library at each voltage point
- *With iterative voltage scaling, we can find minimum operating voltage*

# Heuristic Implementation – Optimize Paths



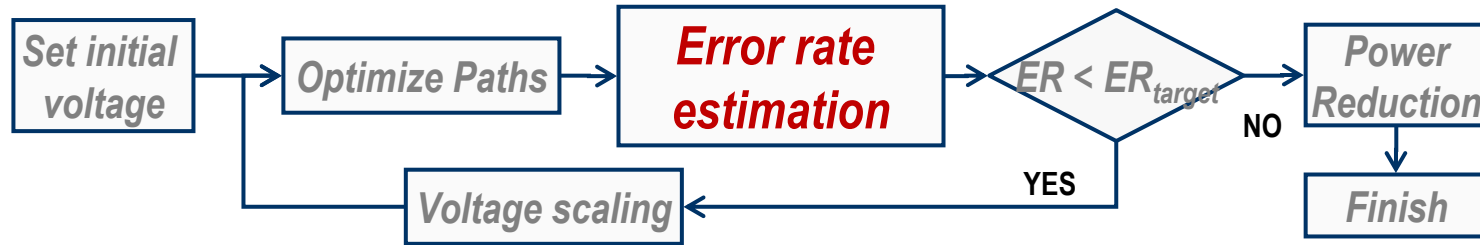
- **Main idea:** increase slack of frequently-exercised paths in order of increasing switching activity
- **Procedure**
  1. Pick a critical path  $p$  with maximum switching activity
  2. Resize cell instance  $c_i$  in  $p$
  3. If slack of path  $p$  is not improved, cell change is restored
  4. Repeat 2. ~ 3. for all cell instances in path  $p$
  5. Repeat 2. ~ 4. for all critical paths
- *OptimizePaths procedure reduces error rates and enables further voltage scaling*

# Heuristic Implementation – Power Reduction



- **Main idea:** Downsize cells on rarely-exercised paths in order of decreasing toggle rate
- **Procedure**
  1. Pick a cell **c** with minimum toggle rate
  2. Downsize cell **c** with logically equivalent cell
  3. Incremental timing analysis and check error rate
  4. If error rate is increased, cell change is restored
  5. Repeat 1. ~ 4.
- *PowerReduction procedure reduces power without affecting error rate*

# Heuristic Implementation – Error Rate Estimation



- Error rate estimation: use toggle rate from SAIF(Switching Activity Interchange Format)
- Error rate contribution of one flip-flop
- Error rate of an entire design

$$ER_{ff} = TG_{ff} \cdot \frac{\sum_{P_1} TG_{P_1}}{\sum_{P_3} TG_{P_3}}$$

$P_1$  (circled)  $P_2$  (circled)  $P_3$  (circled)

$$ER_D = \alpha \cdot \sum_{ff \in D} ER_{ff}$$

$\alpha$ : compensation parameter

$TG(P_1) = 0.3$      $Slack(P_1) = \text{positive}$

• We estimate error rates without functional simulation

$TG(P_2) = 0.2$      $Slack(P_2) = \text{negative}$

$TG(P_3) = 0.1$      $Slack(P_3) = \text{positive}$

$TG(X) = 0.6$

$$ER(X) = TG(X) \cdot \frac{TG(P_2)}{TG(P_1) + TG(P_2) + TG(P_3)} = 0.2$$

# Power Reduction Through Slack Redistribution

- Power consumption @BTWC

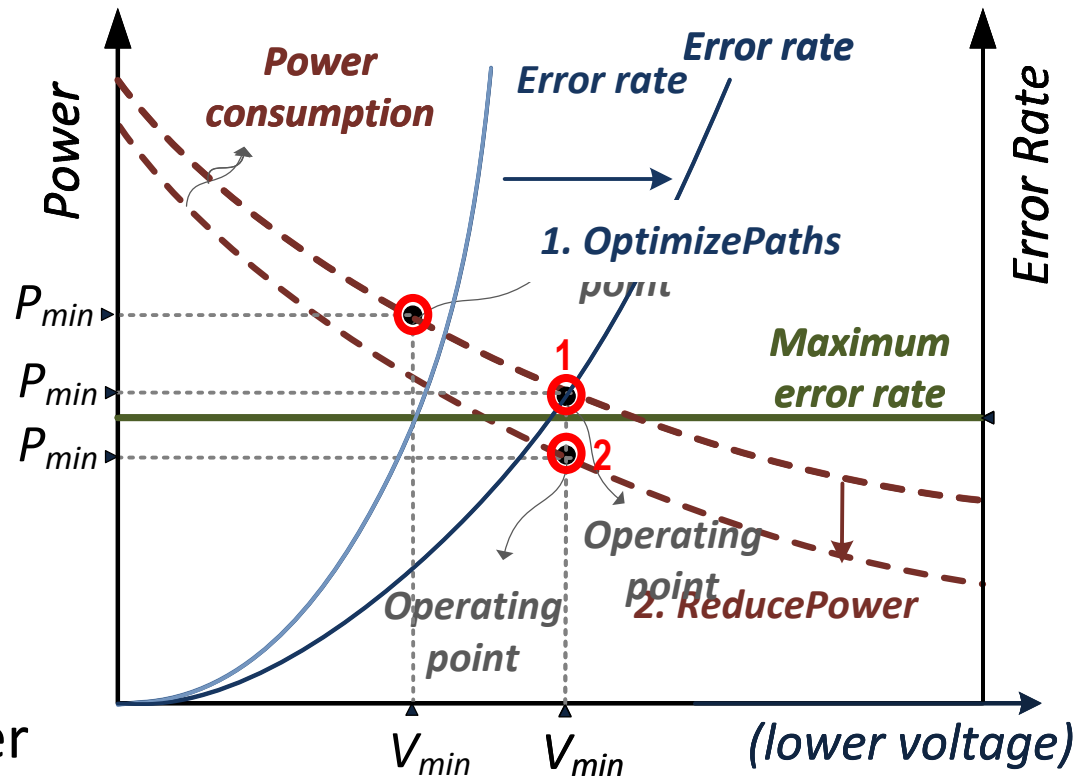
- Minimum power  $P_{min}$  is obtained at minimum operating voltage  $V_{min}$

## 1. OptimizePaths

- Minimize error rate
- Enable to scale voltage further

## 2. ReducePower

- Downsize cells
- Obtain additional power reduction



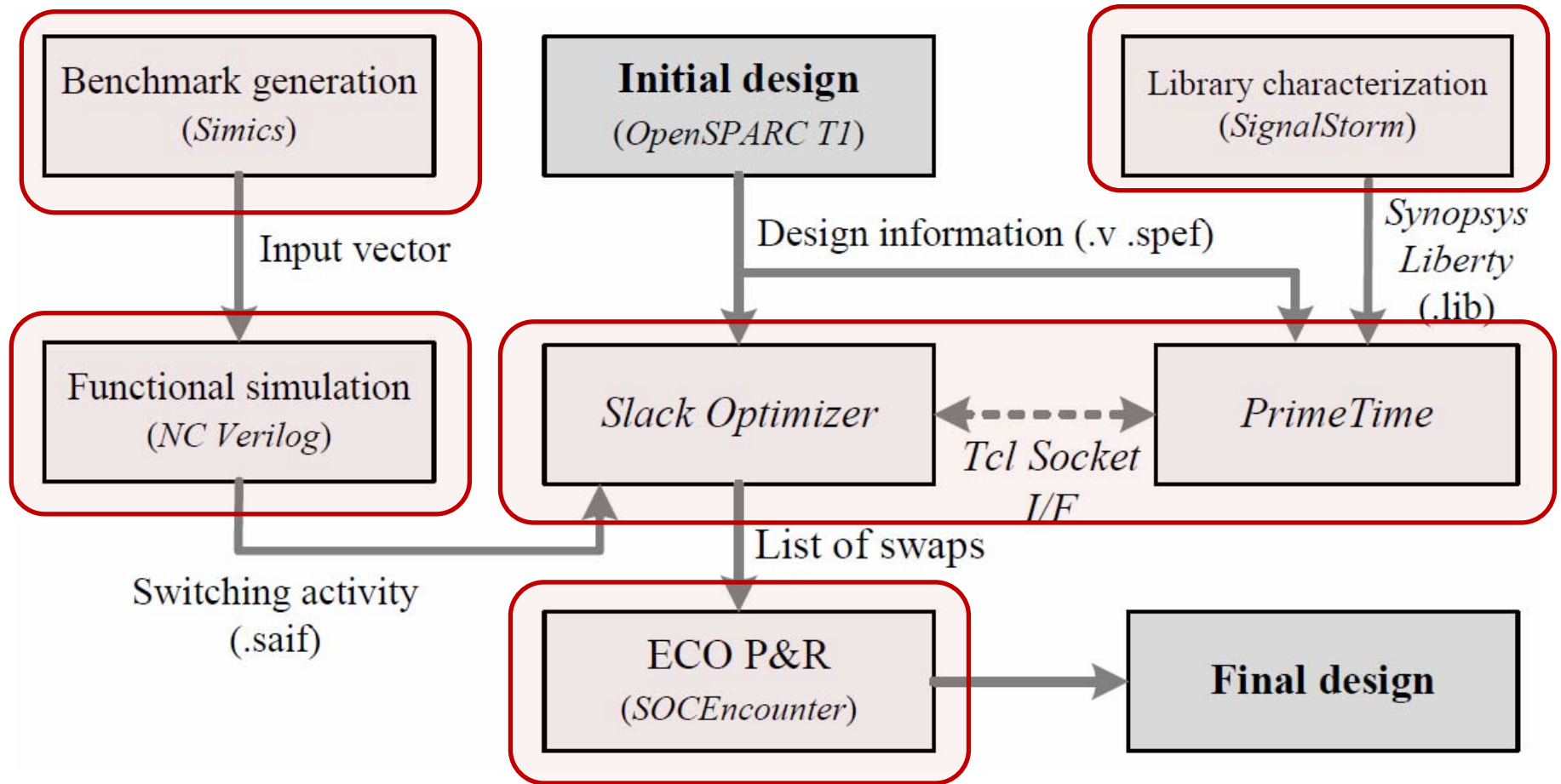
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# Design Methodology



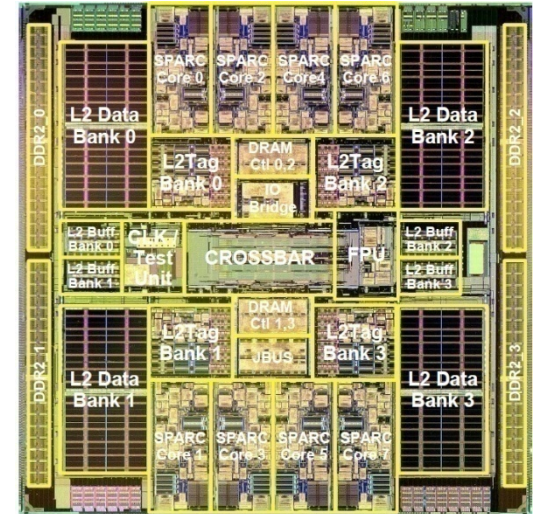
- Benchmark generation (Simics)

- [Code generation \(OpenSPARC T1\)](#) and [Library characterization \(SignalStorm\)](#) are both integrated into the [Synopsys PrimeTime](#) tool.

# Testbed

- Target design : sub-modules of *OpenSPARC T1*

Module	Stage	Description	Cell #
lsu_dctl	MEM	L1 Dcache Control	4537
lsu_qctl1	MEM	LDST Queue Control	2485
lsu_stb_ctl	MEM	ST Buffer Control	854
sparc_exu_div	EX	Integer Division	4809
sparc_exu_ecl	EX	Execution Unit Control Logic	2302
sparc_ifu_dec	FD	Instruction Decode	802
sparc_ifu_errdp	FD	Error Datapath	4184
sparc_ifu_fcl	FD	L1 Icache and PC Control	2431
spu_ctl	SPU	Stream Processing Control	3341
tlu_mmu_ctl	MEM	MMU Control	1701



- Benchmark
  - Ammp, bzip2, equake, sort and twofish
  - Make test vectors with 1 billion cycles for each sub-module
- Implementation
  - TSMC 65GP technology with standard SP&R flow



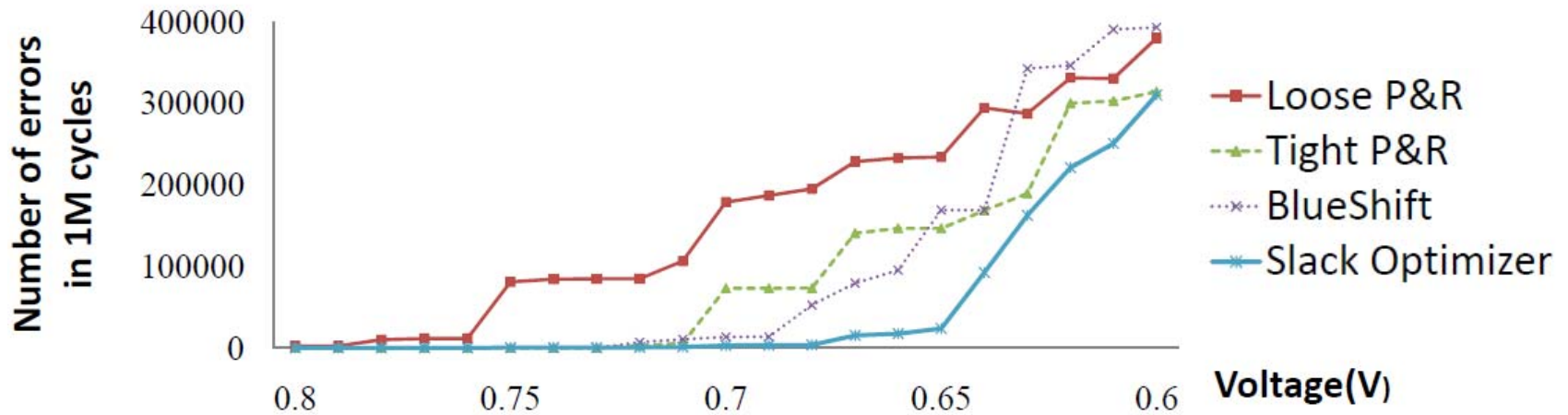
# List of Experiments

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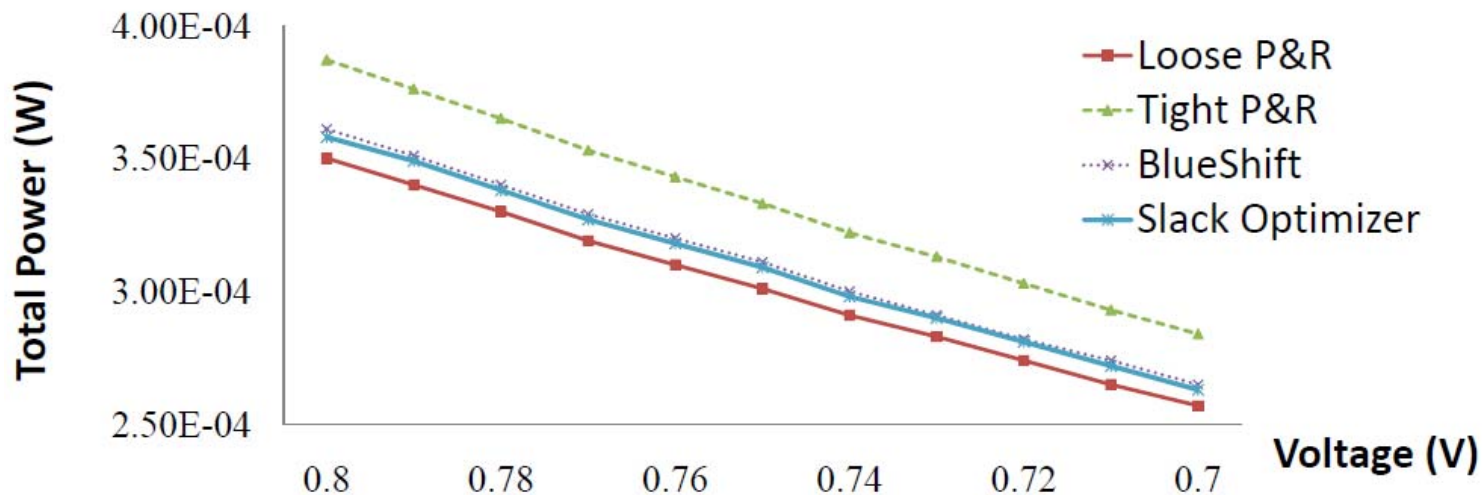
- Design techniques
  1. SP&R with 0.8 GHz (loose constraints)
  2. SP&R with 1.2 GHz (tight constraints)
  3. *Blueshift*: timing override
  4. Slack Optimizer
- Experiments compare all design techniques with respect to:
  1. Power consumption at each voltage point
  2. Actual error rates from gate level simulation
  3. Power consumption at each target error rate
  4. Estimated processor-wide power consumption

# Error Rate and Power Results

- Error rate at each operating voltage (test case : *lsu\_dctl*)

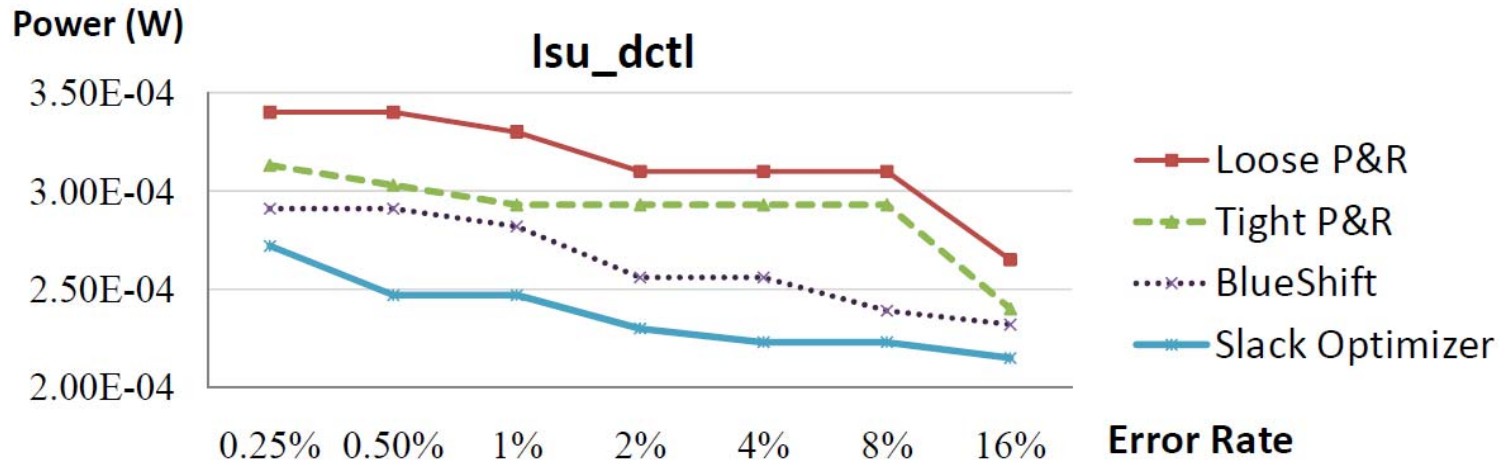


- Power consumption at each operating voltage

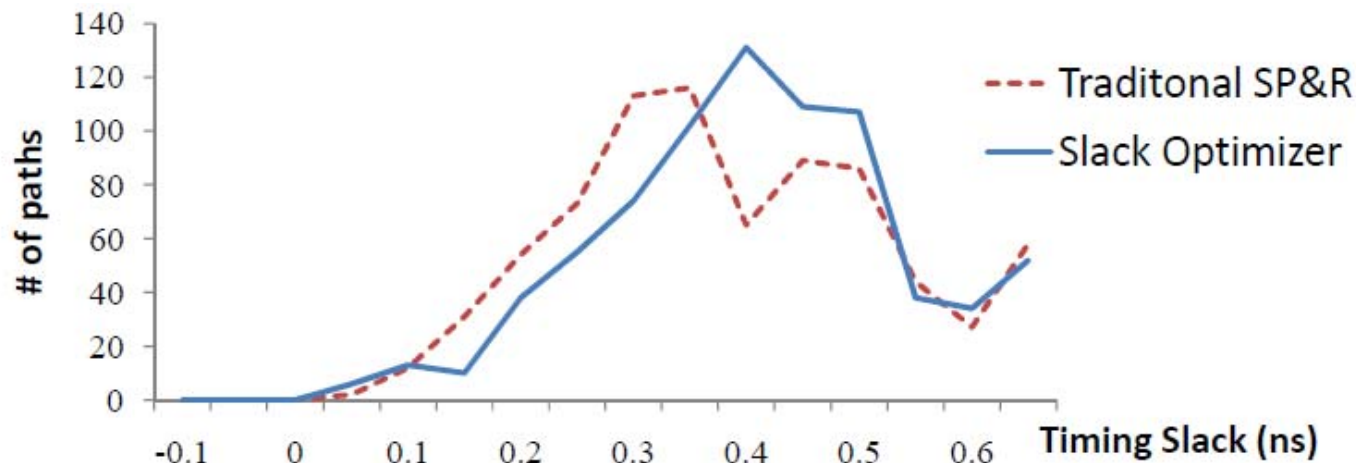


# Comparison of Power and Slack Results

- Power consumption at each target error rate



- Slack distribution



# Power Reduction and Area Overhead

- Power reduction after optimization (@ 2% error rate)

Design	Actual results (after ECO and simulation)							
	Before optimization		After <i>slack optimizer</i>			After <i>power reduction</i>		
	Voltage (V)	Power (W)	Voltage (V)	Power (W)	Reduction (%)	Voltage (V)	Power (W)	Reduction (%)
lsu_dctl	0.76	3.10E-4	0.66	2.41E-4	22.26	0.66	2.30E-4	25.81
lsu_qctl1	0.86	2.36E-4	0.82	2.14E-4	9.32	0.82	2.11E-4	10.59
lsu_stb_ctl	0.71	4.61E-5	0.66	4.04E-5	12.36	0.66	3.99E-5	13.45
sparc_exu_div	0.5	1.06E-4	0.5	1.06E-4	0.00	0.5	1.05E-4	0.94
sparc_exu_ecl	0.91	2.41E-4	0.74	1.63E-4	32.37	0.74	1.62E-4	32.78
sparc_ifu_dec	0.66	2.46E-5	0.63	2.38E-5	3.25	0.63	2.37E-5	3.66
sparc_ifu_errdp	0.51	1.11E-4	0.51	1.12E-4	-0.90	0.51	1.10E-4	0.90
sparc_ifu_fcl	0.85	1.77E-4	0.74	1.38E-4	22.03	0.74	1.35E-4	23.73
spu_ctl	0.59	1.13E-4	0.56	1.02E-4	9.73	0.56	9.99E-5	11.59
tlu_mmu_ctl	0.5	4.62E-5	0.5	4.62E-5	0.00	0.5	4.56E-5	1.30

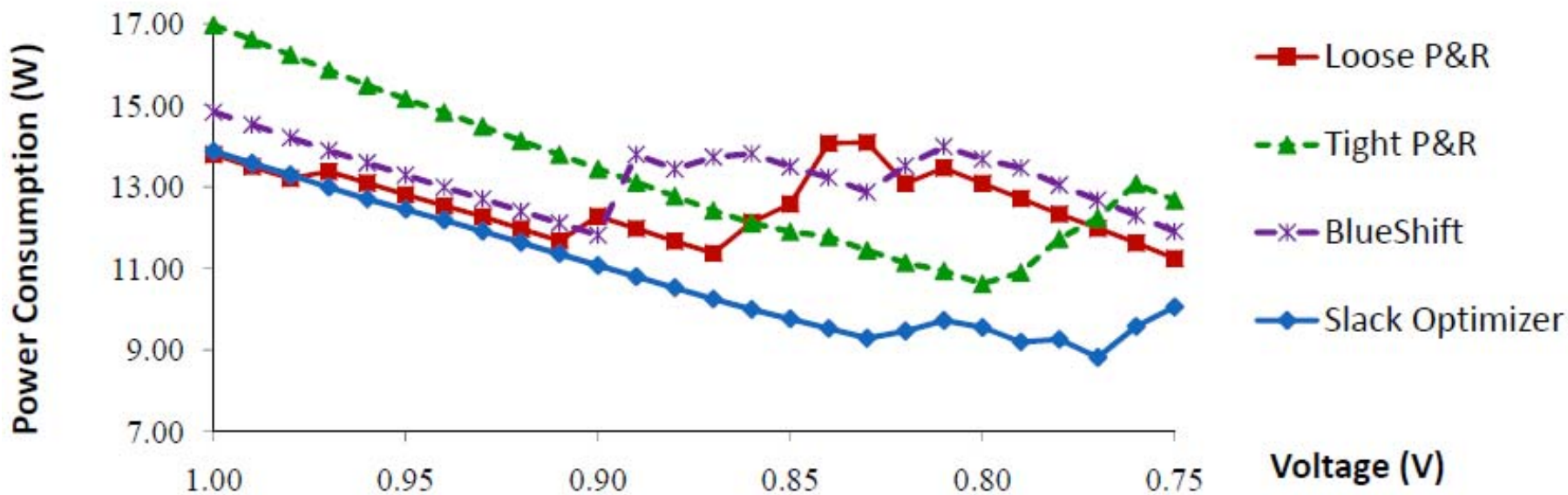
**Max. 32.8 %, Avg. 12.5% power reduction**

- Area overhead of design approaches

Tight P&R	<i>BlueShift</i>	<i>Slack Optimizer</i>	<i>SlackOpt + PowerReduce</i>
20.3%	6.5%	2.7%	2.7%

# Processor-wide Results

Processor Power Consumption with Razor Correction \*



\*Kahng et al. "Designing a Processor From the Ground Up to Allow Voltage/Reliability Tradeoffs", *HPCA* 2010.

- *Slack optimization extends range of voltage scaling and reduces Razor recovery cost*

# Conclusions and Ongoing Work

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- Showed limitations of a BTWC design
- Presented design technique – **slack redistribution**
  - Optimize frequently exercised critical paths
  - De-optimize rarely-exercised paths
- Demonstrated significant power benefits of gradual slack design
  - **Reduced power 33% on maximum , 12.5% on average**
- Ongoing work
  - Reliability-power tradeoffs for embedded memory
  - Applying to heterogeneous multi-core architecture

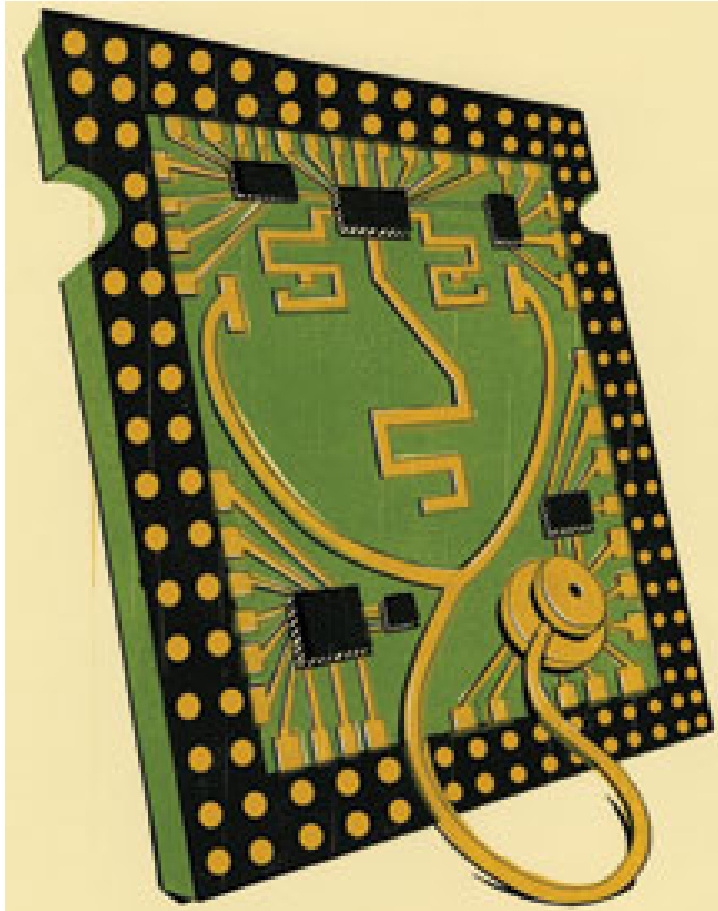


# THANK YOU

# BACKUP

# CPU, Heal Thyself

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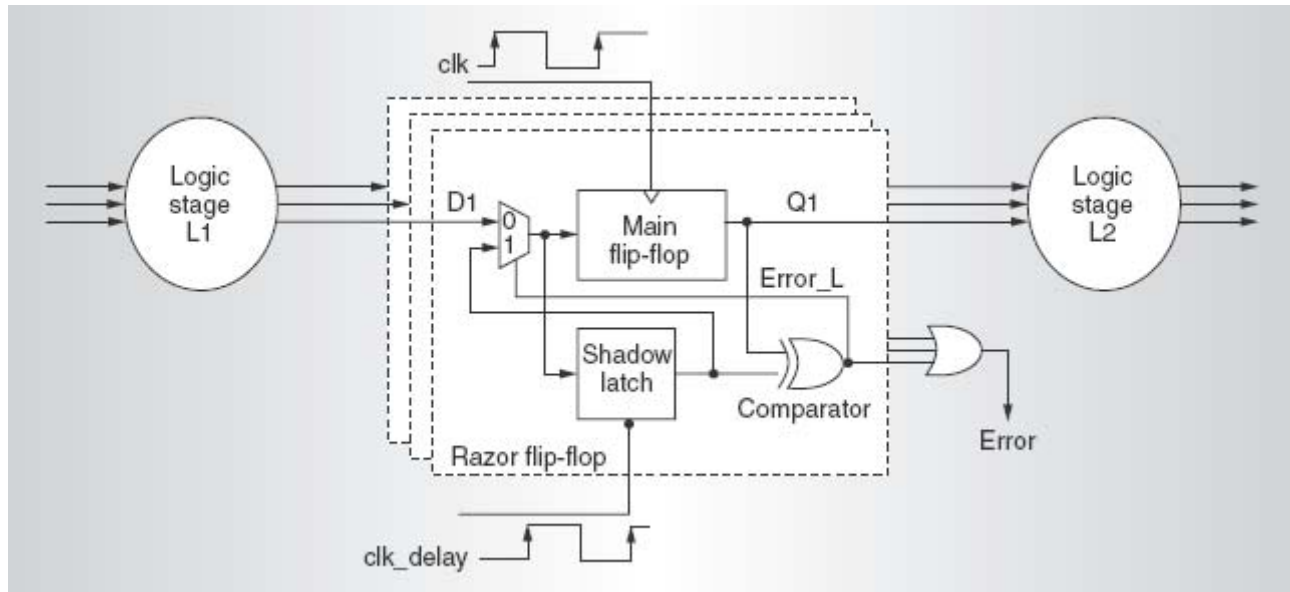


- *Razor\** system
  - Timing errors can be corrected
  - Manage the trade-off between system voltage and error rate
- New design methodology is needed

\* Razor: A low power pipeline based on circuit-level timing speculation.  
*In International Symposium on Micro architecture, December 2003.*

# Razor – How it works

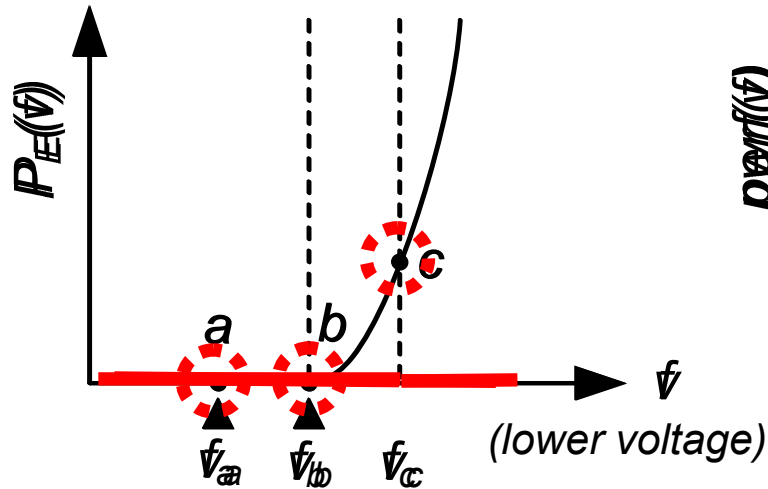
- Razor Implementation



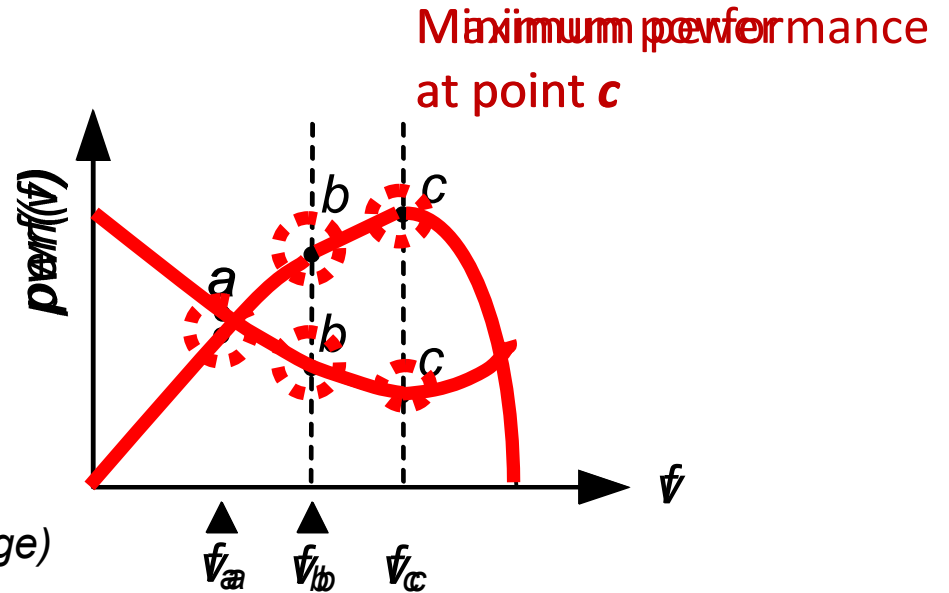
- Razor: A low power pipeline based on circuit-level timing speculation. In International Symposium on Microarchitecture, December 2003.
- Main flip-flop latches at  $T$ , but Shadow latch latches at  $T + \text{skew}$
- If a timing violation occurs, main flip-flop will latch incorrect value, but shadow latch should latch correct value
- Comparator signals error and the late arriving value is fed back into the main flip-flop

# BTWC: Voltage Scaling

- Voltage scaling case**



$P_E(f)$  :: Error rate at frequency  $f$

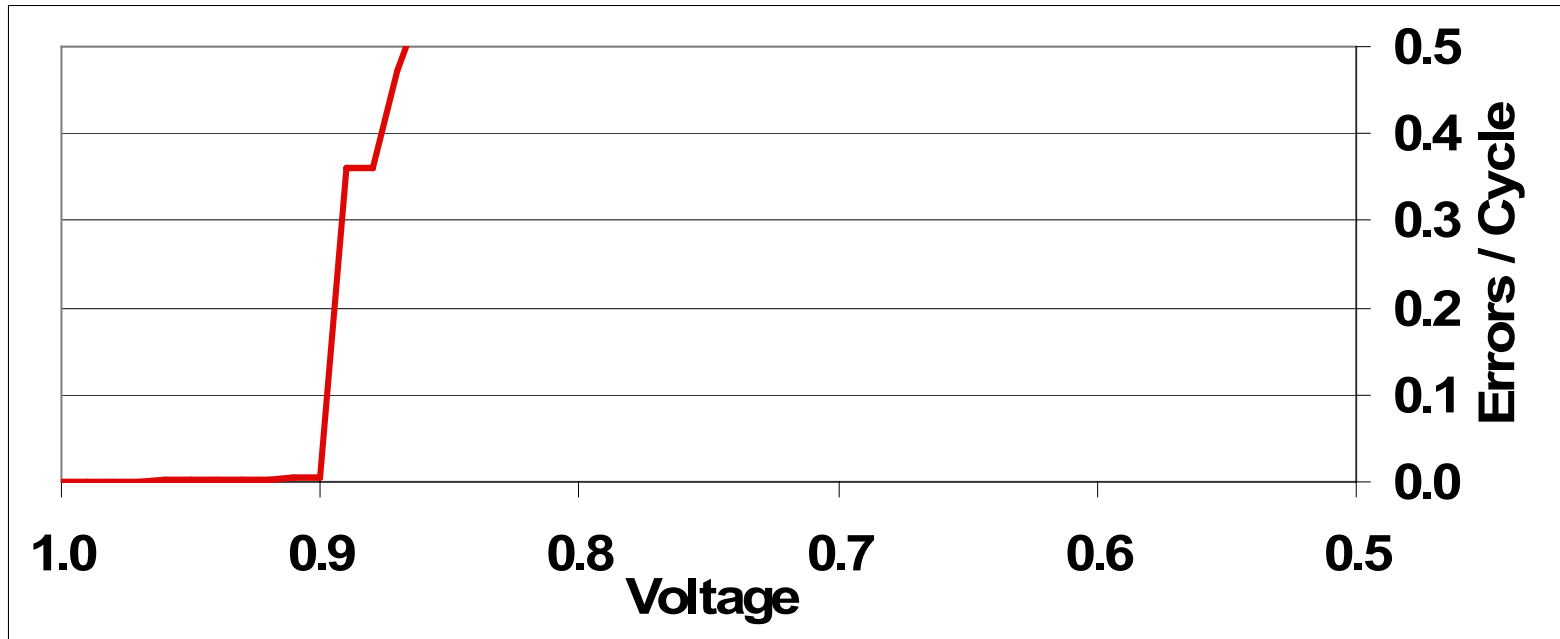


$perf(f)$  : Performance at  $f$

- Error correction needs additional clock cycles and incurs power overhead

# Limitation of Voltage Scaling

- At some voltage, circuit breaks down

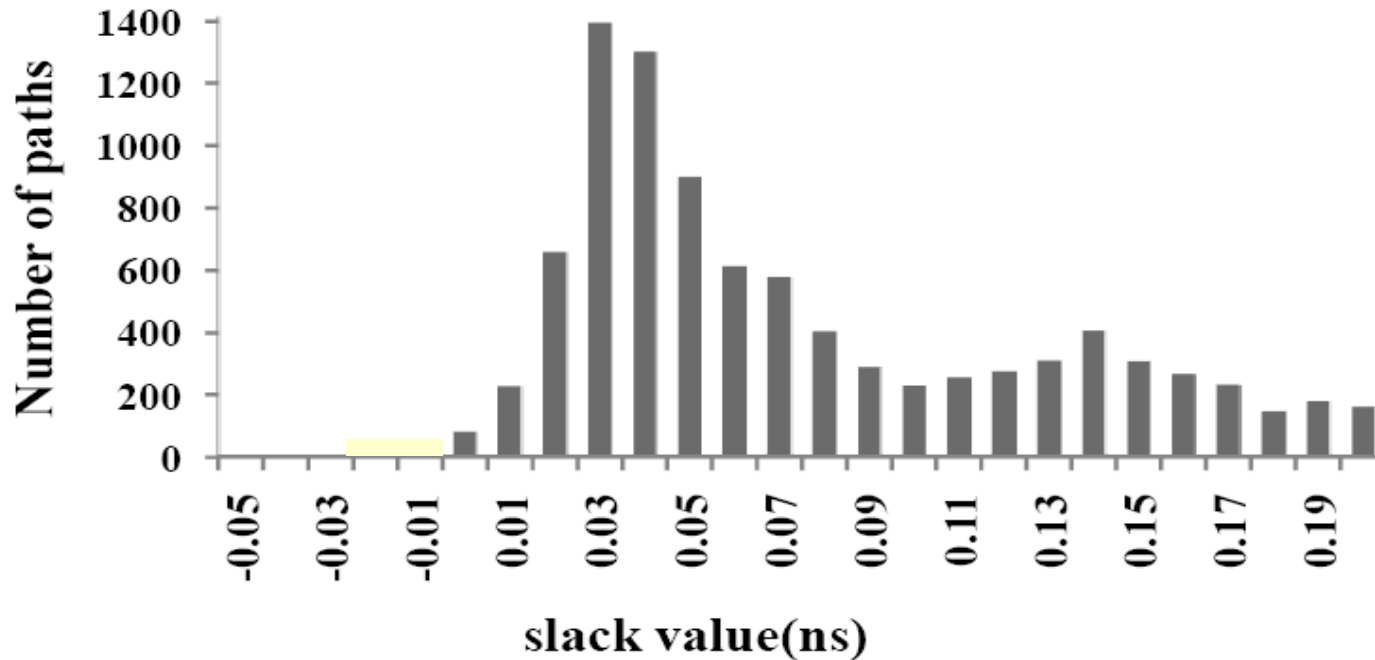


**Voltage scaling must halt after only 10% scaling.**

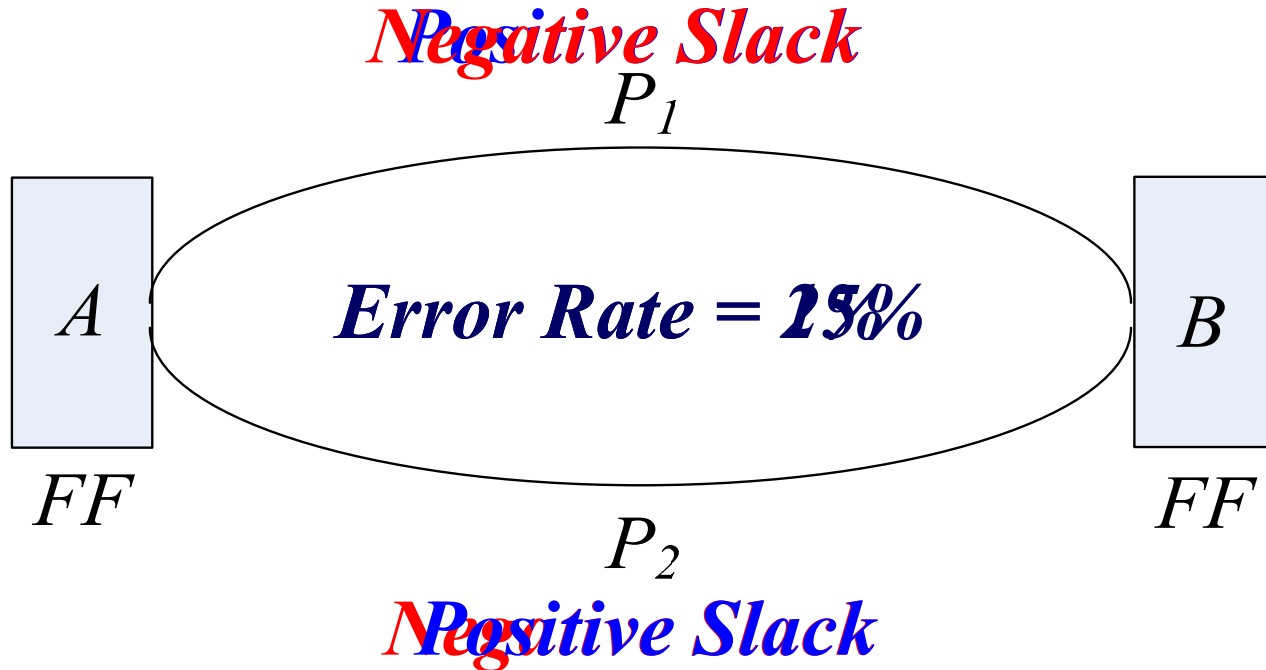
# Reason for Steep Error Degradation

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- Critical paths are bunched up in traditional designs.



# Slack Re-distribution Example



$TG(P_1) = 0.25$	$Slack(P_1) = -0.2$	$0.0$
$TG(P_2) = 0.01$	$Slack(P_2) = 0.1$	$-0.1$



# Heuristic Implementation – Error Rate Estimation

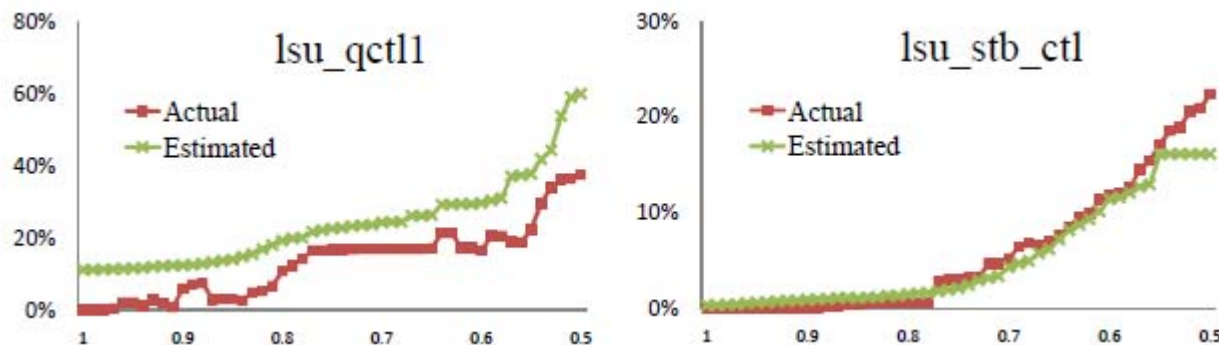
- Error rate contribution of one flip-flop

$$(1) \quad ER_{ff} = TG_{ff} \cdot \frac{\sum TG_{P_{NEG}}}{\sum TG_{P_{ALL}}}$$

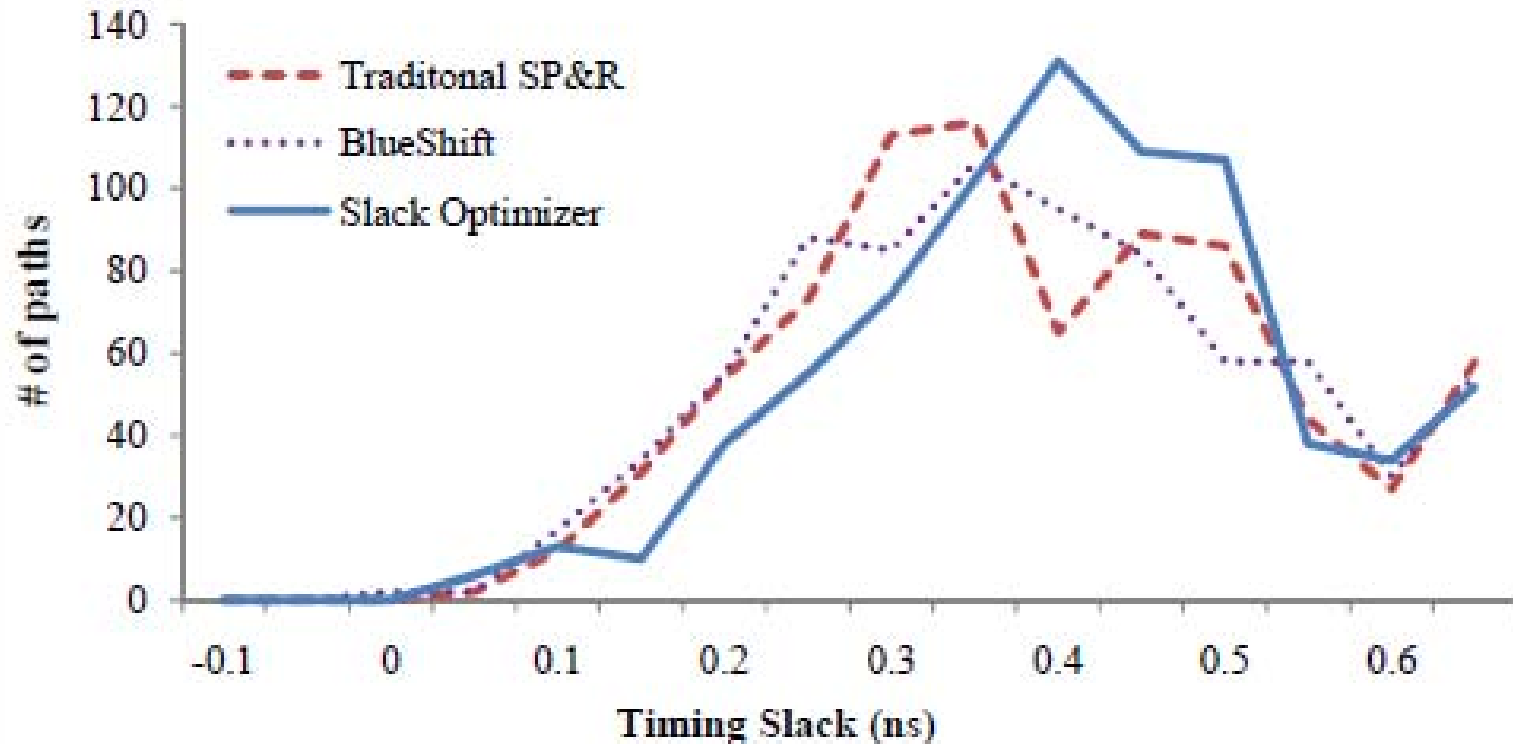
- Error rate of an entire design

$$(2) \quad ER_D = \alpha \cdot \sum_{ff \in D} ER_{ff} \quad \alpha : \text{compensation parameter}$$

- Actual vs. estimated error rates

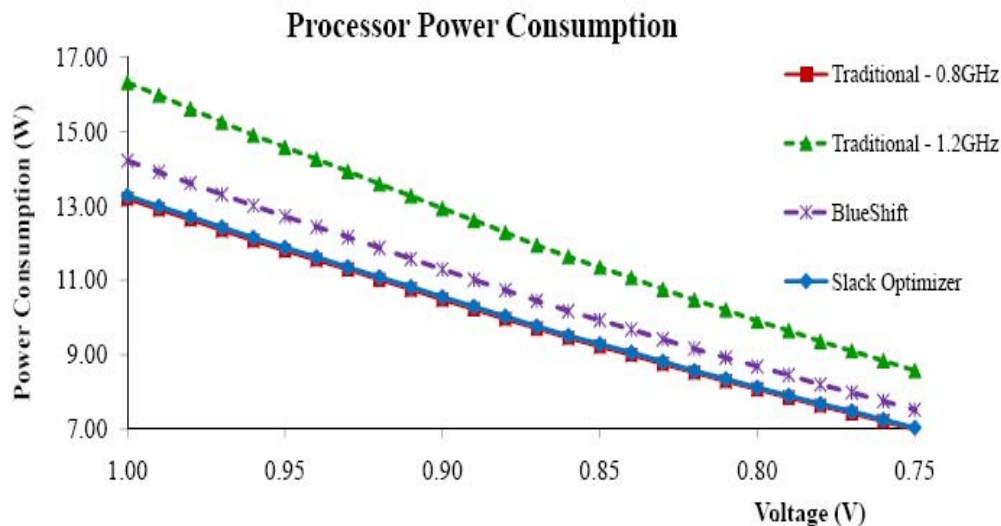
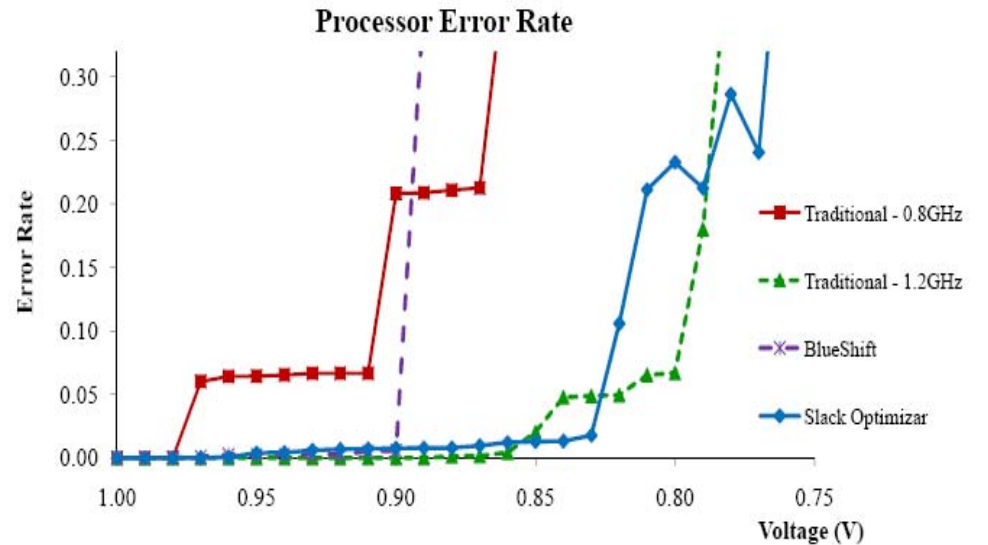


# Gradual Slack Distribution



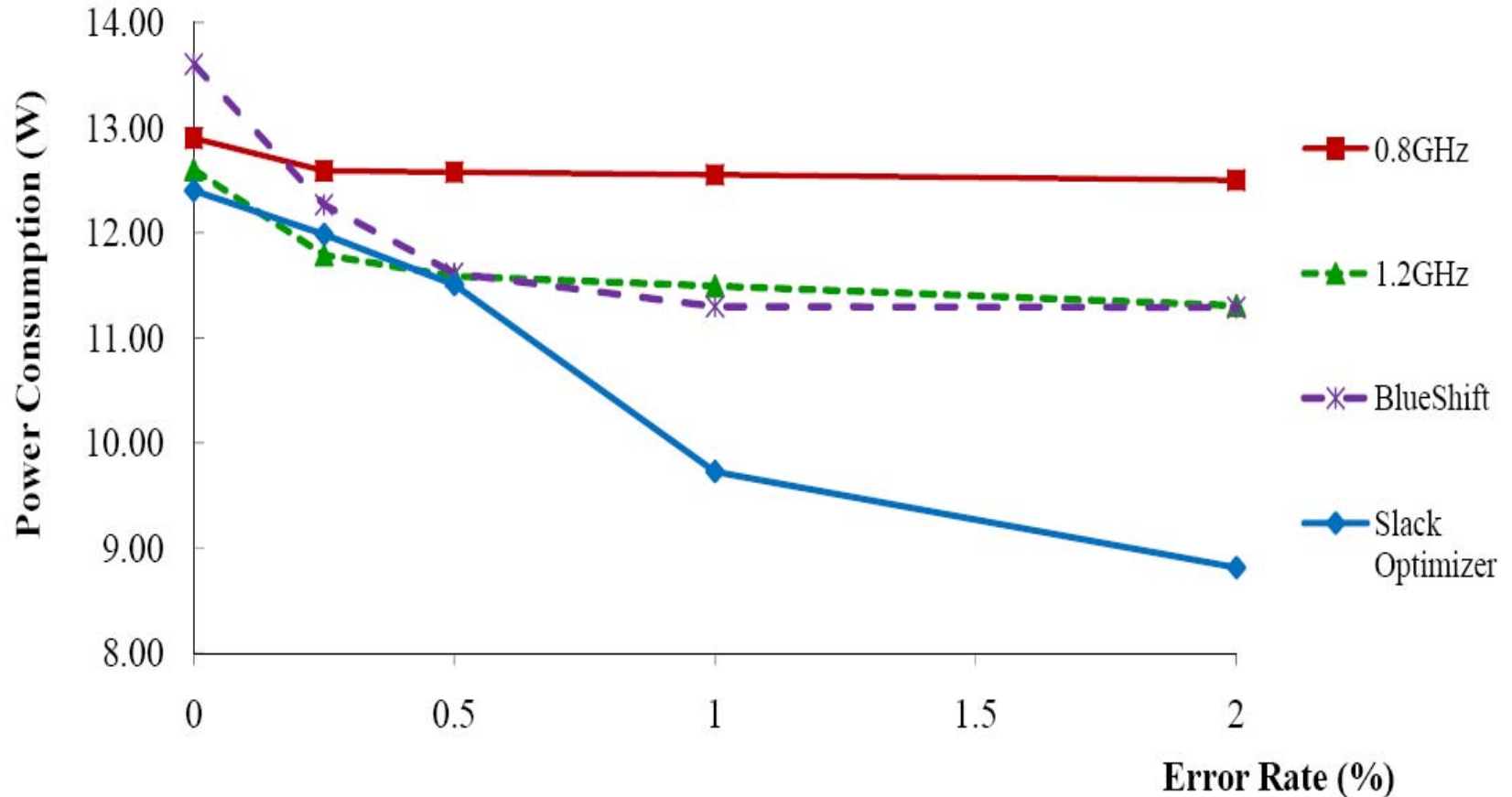
**Slack optimization achieves gradual slack distribution.**

# Processor Error Rate and Power



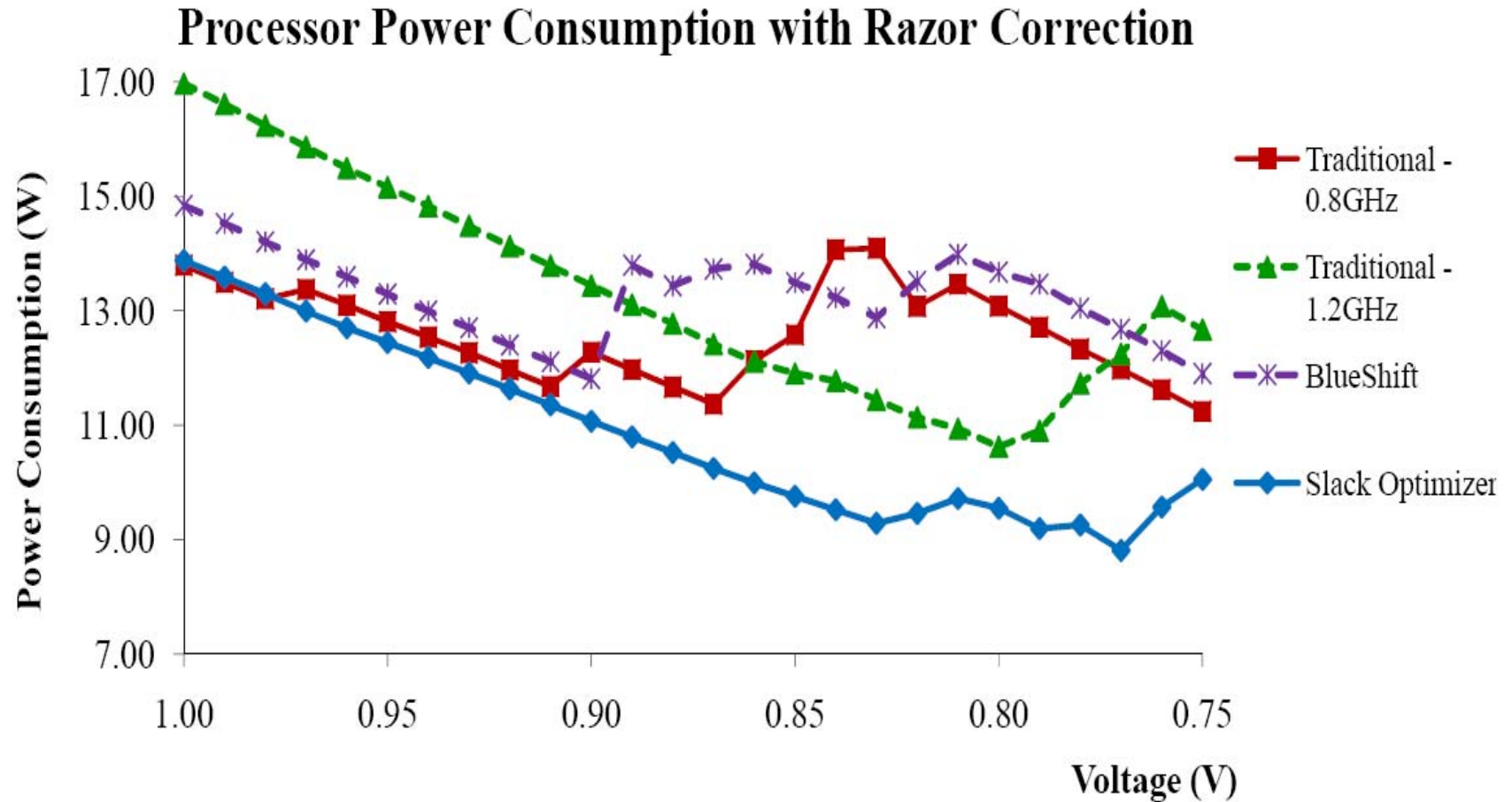
Designs with comparable error rates have much higher power/area overheads.

# Reliability/Power Tradeoff



**Slack-optimized design enjoys continued power reduction as error rate increases.**

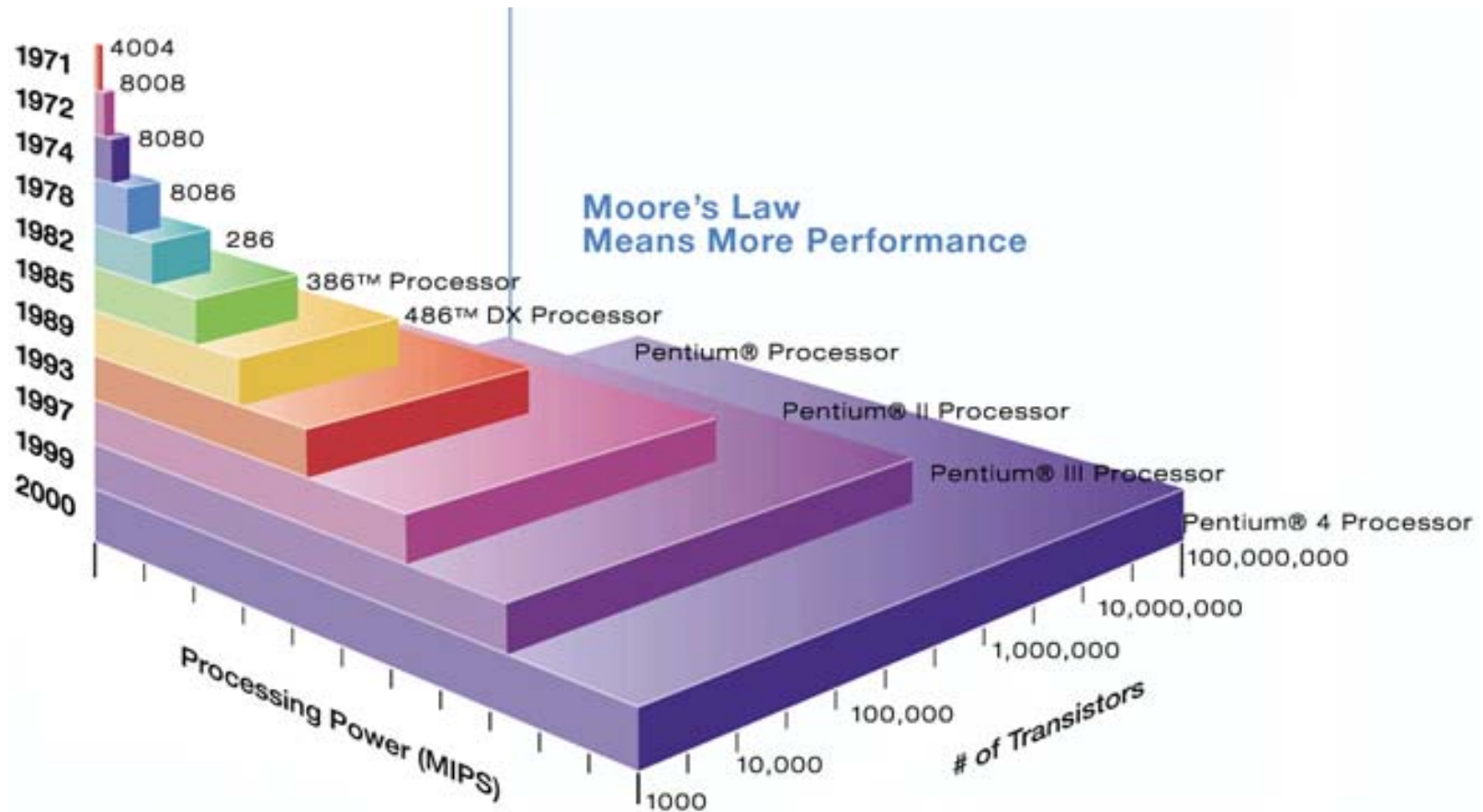
# Enhancing Razor-based Design



**Slack optimization extends range of voltage scaling and reduces Razor recovery cost.**

# Moore's Law

- Power consumption of processor node doubles every 18 months.



# Power Scaling

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- With current design techniques, processor power soon on par with nuclear power plant

